Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/045,606	SHIN ET AL.	
Examiner	Art Unit	
Steven Blount	2661	

	SEARCHED			
Class	Subclass	Date	Examiner	
370	389	X1/05	\Diamond	
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	230.1			
	465			
	463	V	Y	
370	471	9/1/05	X	

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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